



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. .... 10/053,201  
Confirmation No. .... 4057  
Filing Date .... January 15, 2002  
Inventor .... Harry Rosenberg, et al.  
Assignee .... Honeywell International Inc.  
Group Art Unit .... 2818  
Examiner .... P. Dang  
Attorney's Docket No. .... 34593-CON1  
Customer No. .... 021567  
Title: Tantalum Sputtering Target and Method of Manufacture

**INFORMATION DISCLOSURE STATEMENT**  
**PURSUANT TO 37 C.F.R. §§ 1.56, 1.97 AND 1.98**

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed together with the filing of the Request for Continued Examination (RCE) Application and before receipt of the first Office Action. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. §1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Citation of these references is respectfully requested.

Respectfully submitted,

Dated:

29 Aug 2003

By:

James E. Lake  
Reg. No. 44,854

Form PTO-1449 AUG 29 2003 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 34593-CON1		SERIAL NO. 10/053,201	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Harry Rosenberg et al			
				FILING DATE January 15, 2002		GROUP 2818	
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	5,244,556	09/1993	Inoue			
	AB	3,984,208	10/1976	Moulin et al			
	AC	5,972,288	10/1999	Jeong et al			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation
							Yes No
	AJ						
	AK						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AL						
	AM						
	AN						
	AO						
	AP						
	AQ						
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	AS						
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EXAMINER				DATE CONSIDERED			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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